**Product data sheet** 

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**NXP Semiconductors** 



NXP Semiconductors Product specification

Silicon PIN diode BAP63-02

#### **FEATURES**

- High speed switching for RF signals
- Low diode capacitance
- · Low diode forward resistance
- Very low series inductance
- For applications up to 3 GHz.

#### **APPLICATIONS**

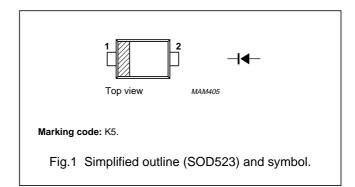
• RF attenuators and switches.

## **DESCRIPTION**

Planar PIN diode in a SOD523 ultra small SMD plastic package.

#### **PINNING**

PIN	DESCRIPTION	
1	cathode	
2	anode	



#### **LIMITING VALUES**

In accordance with the Absolute Maximum Rating System (IEC 60134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
$V_R$	continuous reverse voltage		_	50	V
I <sub>F</sub>	continuous forward current		_	100	mA
P <sub>tot</sub>	total power dissipation	T <sub>s</sub> ≤ 90 °C	_	715	mW
T <sub>stg</sub>	storage temperature		-65	+150	°C
Tj	junction temperature		-65	+150	°C

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## **ELECTRICAL CHARACTERISTICS**

 $T_i = 25$  °C unless otherwise specified.

SYMBOL PARAMETER CONDITIONS		TYP.	MAX.	UNIT	
V <sub>F</sub>	forward voltage	I <sub>F</sub> = 50 mA	0.95	1.1	V
I <sub>R</sub>	reverse leakage current	V <sub>R</sub> = 35 V	_	10	nA
C <sub>d</sub>	diode capacitance	V <sub>R</sub> = 0; f = 1 MHz	0.36	_	pF
		V <sub>R</sub> = 1 V; f = 1 MHz	0.32	_	pF
		V <sub>R</sub> = 20 V; f = 1 MHz	0.25	0.32	pF
r <sub>D</sub>	diode forward resistance	I <sub>F</sub> = 0.5 mA; f = 100 MHz; note 1	2.5	3.5	Ω
		I <sub>F</sub> = 1 mA; f = 100 MHz; note 1	1.95	3	Ω
		I <sub>F</sub> = 10 mA; f = 100 MHz; note 1	1.17	1.8	Ω
		I <sub>F</sub> = 100 mA; f = 100 MHz; note 1	0.9	1.5	Ω
s <sub>21</sub>   <sup>2</sup>	isolation	V <sub>R</sub> = 0; f = 900 MHz	15.6	_	dB
		V <sub>R</sub> = 0; f = 1800 MHz	10.3	_	dB
		V <sub>R</sub> = 0; f = 2450 MHz	8.3	_	dB
\$ <sub>21</sub>   <sup>2</sup>	insertion loss	I <sub>F</sub> = 0.5 mA; f = 900 MHz	0.19	_	dB
		I <sub>F</sub> = 0.5 mA; f = 1800 MHz	0.24	_	dB
		I <sub>F</sub> = 0.5 mA; f = 2450 MHz	0.28	_	dB
S <sub>21</sub>   <sup>2</sup>	insertion loss	I <sub>F</sub> = 1 mA; f = 900 MHz	0.16	_	dB
		I <sub>F</sub> = 1 mA; f = 1800 MHz	0.20	_	dB
		I <sub>F</sub> = 1 mA; f = 2450 MHz	0.25	_	dB
S <sub>21</sub>   <sup>2</sup>	insertion loss	I <sub>F</sub> = 10 mA; f = 900 MHz	0.10	_	dB
		I <sub>F</sub> = 10 mA; f = 1800 MHz	0.16	_	dB
		I <sub>F</sub> = 10 mA; f = 2450 MHz	0.20	_	dB
S <sub>21</sub>   <sup>2</sup>	insertion loss	I <sub>F</sub> = 100 mA; f = 900 MHz	0.09	_	dB
		I <sub>F</sub> = 100 mA; f = 1800 MHz	0.14	_	dB
		I <sub>F</sub> = 100 mA; f = 2450 MHz	0.18	_	dB
τ∟	charge carrier life time	when switched from $I_F$ = 10 mA to $I_R$ = 6 mA; $R_L$ = 100 $\Omega$ ; measured at $I_R$ = 3 mA	310	-	ns
L <sub>S</sub>	series inductance	I <sub>F</sub> = 100 mA; f = 100 MHz	0.6	_	nH

## Note

# THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	VALUE	UNIT
R <sub>th j-s</sub>	thermal resistance from junction to soldering point	85	K/W

<sup>1.</sup> Guaranteed on AQL basis: inspection level S4, AQL 1.0.

NXP Semiconductors Product specification

# Silicon PIN diode BAP63-02

#### **GRAPHICAL DATA**

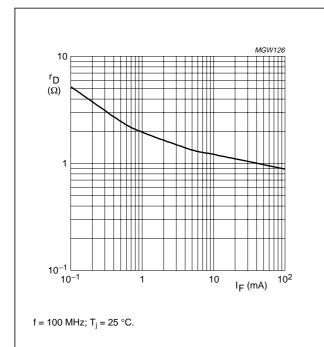


Fig.2 Forward resistance as a function of forward current; typical values.

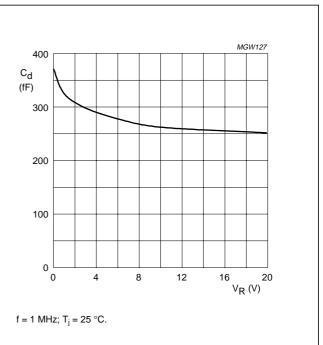
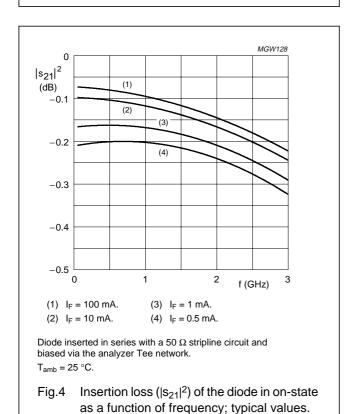
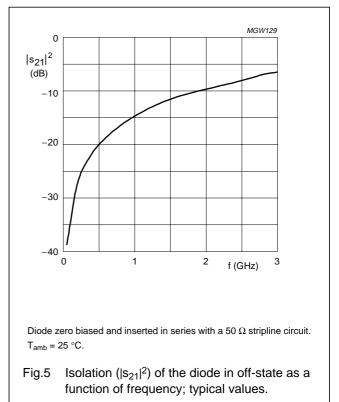


Fig.3 Diode capacitance as a function of reverse voltage; typical values.





**NXP Semiconductors** Product specification

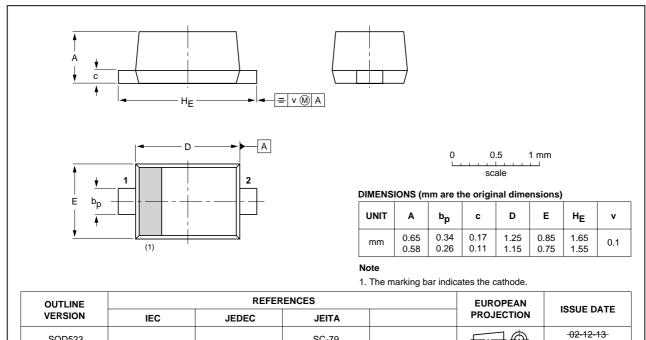
BAP63-02 Silicon PIN diode

## **PACKAGE OUTLINE**

SOD523

## Plastic surface-mounted package; 2 leads

**SOD523** 



SC-79

06-03-16

NXP Semiconductors BAP63-02

Silicon PIN diode

# Legal information

#### **Data sheet status**

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
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NXP Semiconductors BAP63-02

Silicon PIN diode

# **Revision history**

## **Revision history**

Document ID	Release date	Data sheet status	Change notice	Supersedes	
BAP63-02_N_4	20080108	Product data sheet	-	BAP63-02_3	
Modifications:  • Package outline drawing on page 5 changed					
BAP63-02_3 (9397 750 08261)	20010518	Product specification	-	BAP63-02_N_2	
BAP63-02_N_2 (9397 750 08141)	20010320	Preliminary specification	-	BAP63-02_N_1	
BAP63-02_N_1 (9397 750 08051)	20010220	Preliminary specification	-	-	

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